

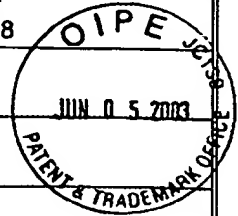
SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 213035US2PCT		SERIAL NO. 09/926,068	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hiroyuki KAWAI, et al.		RECEIVED APR 18 2002 Technology Center 2600	
				FILING DATE December 12, 2001			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
M.G.	AA	5,914,950	06/22/99	E. G. TIEDEMANN JR., et al.	—	—	
	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
M.G.	AO	9-247731	09/19/97	JAPAN (submitting English translation only)			
M.G.	AP	1-029030	01/31/89	JAPAN (submitting English translation only)			
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner M. G. Gerad					Date Considered 9 February 2006		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hiroyuki KAWAI, et al.			
				FILING DATE December 12, 2001		GROUP 2681	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
M. G.	AA	5,721,733	02/24/98	W. WANG, et al.	—	—	
M. G.	AB	5,995,496	11/30/99	Z. HONKASALO, et al.	—	—	
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
M. G.	AO	WO 96/66755	12/23/99	WIPO			
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	AU						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
M. G.	AW	S. V. HANLY, IEEE Transactions on Communications, vol. 47, no. 3, pages 426-437, XP-000802084, "CONGESTION MEASURES IN DS-CDMA NETWORKS", March 1999					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Mark G. Gersl</i>					Date Considered <i>9 February 2006</i>		
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				FILING DATE December 12, 2001		GROUP 2681	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
M.G.	AA	5,920,817	07/06/99	N. UMEDA, et al.	—	—	
M.G.	AB	5,812,935	09/22/98	S. E. KAY	—	—	
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
M.G.	AO	WO 98/48530	10/29/98	WIPO			
	AP						
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	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>M. G. Genard</i>					Date Considered <i>9 February 2006</i>		
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